

N Channel MOSFET

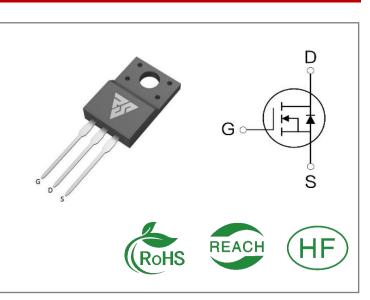
ID	R _{DS} (ON)(Typ)	VDSS
18A	0.28Ω	500V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS18N50F	T0-220F	RS18N50F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS18N50F	Units
VDSS	Drain-to-Source Voltage	500	V
ID	Continuous Drain Current TC=25℃	18	٨
IDM	Pulsed Drain Current (Note*1)	72	A
PD	Power Dissipation	39	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	520	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	Ĉ
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS18N50F	Units	Test Conditions
RÐJC	Junction-to-Case	3.2	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\! \mathbb C$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	500			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=500V,VGS= 0V
IGSS	Gate- to- Source Forward Leakage			100	~^	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.28	0.34	Ω	VGS=10V,ID=9A
VGS(TH)	Gate Threshold Voltage	2		4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		51			
trise	Rise Time		28		nS	VDS=250V ID=18A RG=25Ω
td(OFF)	Turn- OFF Delay Time		157			
tfall	Fall Time		48			



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Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		2415			VGS=0V
Coss	Output Capacitance		219		pF	VDS=25V f=1.0MHz
Crss	Reverse Transfer Capacitance		5.5			
Qg	Total Gate Charge		39.5			VDS=400V
Qgs	Gate- to- Source Charge		12		nC	ID=18A VGS=10V
Qgd	Gate-to-Drain(" Miller") Charge		11.5			

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			18	А	Integral pn- diode
ISM	Maximum Pulsed Current			72	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=9A,VGS=0V
trr	Reverse Recovery Time		310		nS	VGS=0V
Qrr	Reverse Recovery Charge		4.9		μC	IS=18A,di/dt=100 A/µs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve

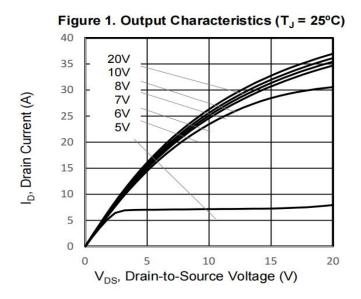
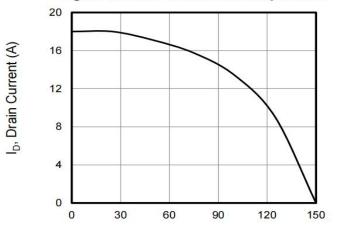
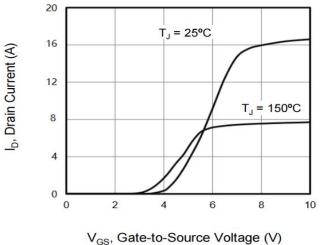


Figure 3. Drain Current vs. Temperature



T_c, Case Temperature (A)

Figure 5. Transfer Characteristics



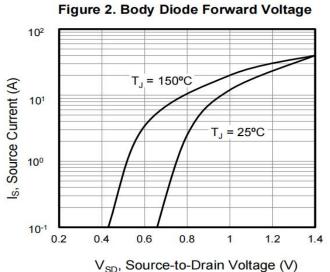


Figure 4. BV_{DSS} Variation vs. Temperature

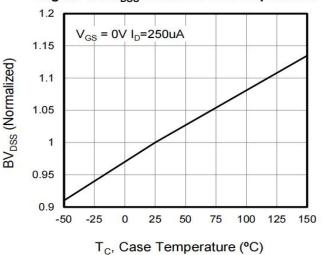
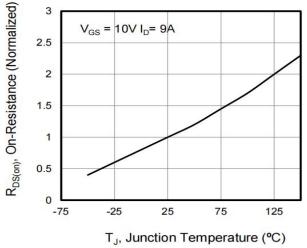


Figure 6. On-Resistance vs. Temperature







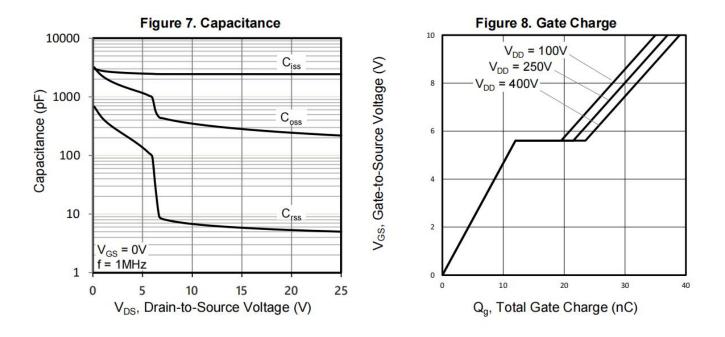
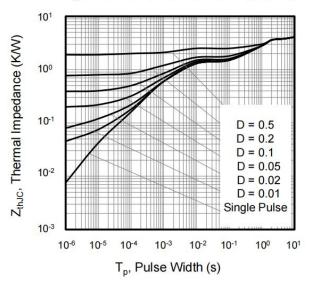


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

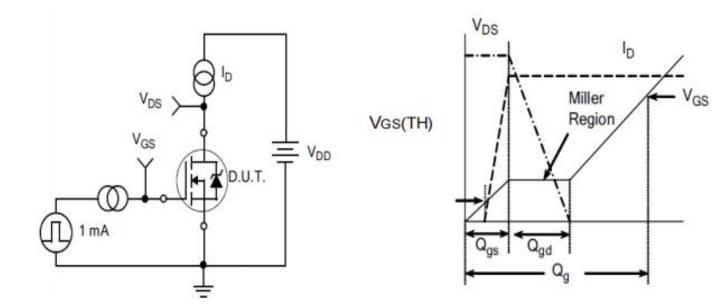
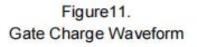


Figure10. Gate Charge Test Circuit



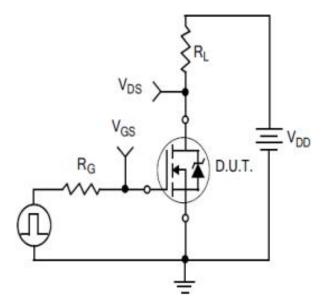


Figure12. Resistive Switching Test Circuit

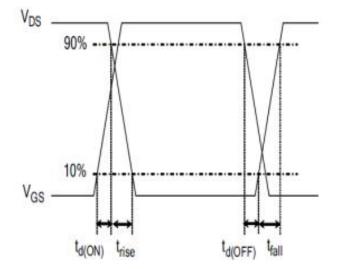
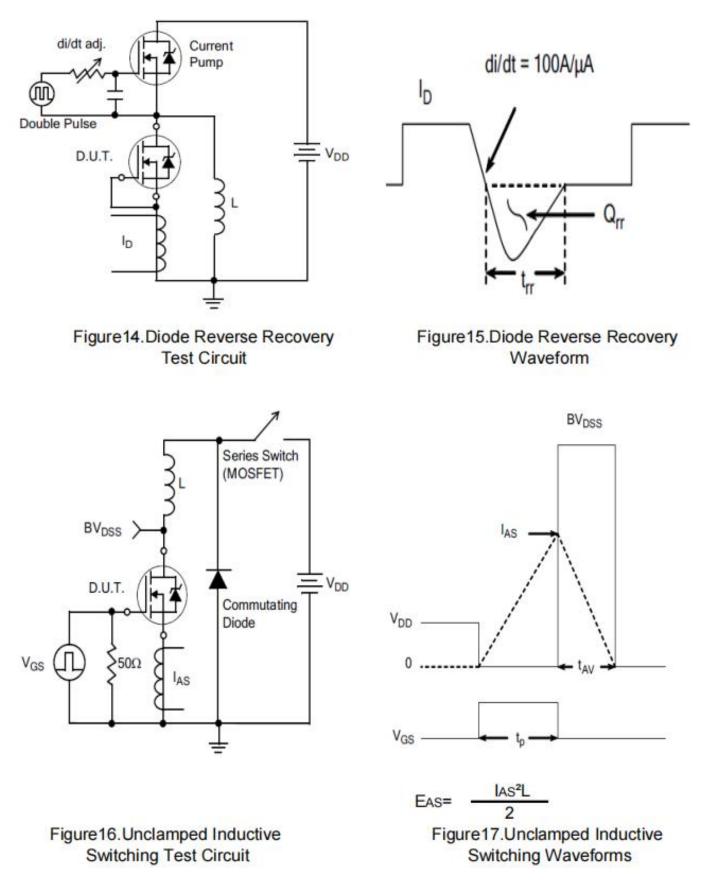


Figure13. Resistive Switching Waveforms

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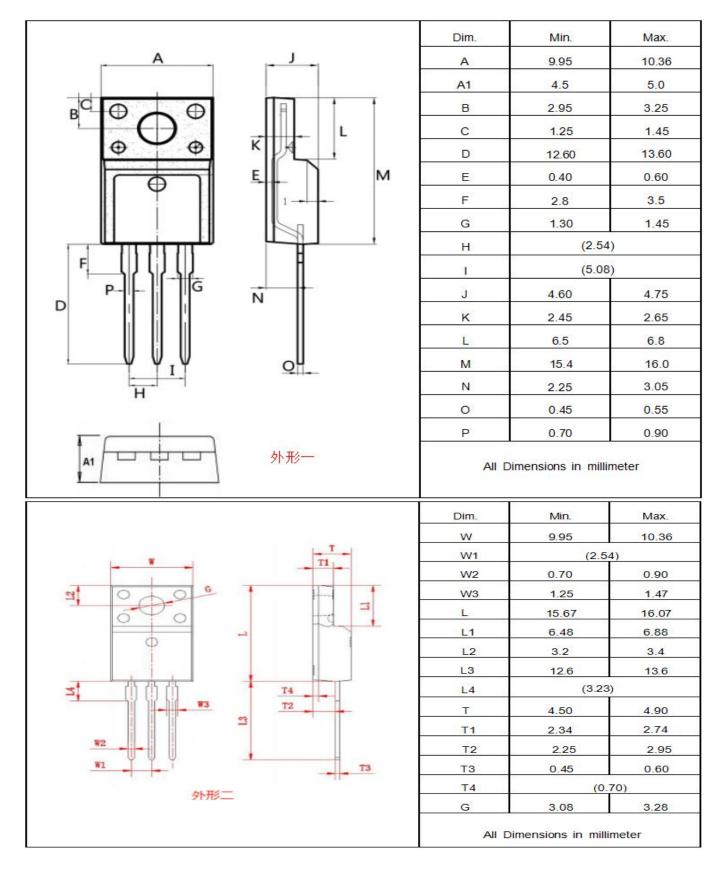
Test Circuits and Waveforms





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Package outline drawing(TO-220F Unit: mm)





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